### LCD defect detection details (Class B)



#### 1. Appearance inspection

Defective item	Legend		Testing sta	andards
Point defects	宽	Φ(mm) (diameter)	judgement	
1. Internal		Φ ≤ 0.1	Excluding	
contamination 2. Impurities	<b>↓</b>	0.1 < Φ ≤ 0.2	2 pieces allow	wed
3. Light	长	0.2 < Φ ≤ 0.25	Accept 1	
leakage and other point	Φ = (L+W) /2	Φ > 0.25		NG
defects (except for the intersection points of normal design)	$\varphi = \langle L   W \rangle / Z$	<ol> <li>When two appear, the distance must be more than 5.0mm.</li> <li>Those outside the visible area are not counted.</li> </ol>		
Linear defects	I	Lenth(mm)	Width(mm)	Judgement
1. Wool 2. Fiber	H	Excluding	≤ 0.02	Excluding
3. Glass scratches and other linear	ab	≤ 5.0	≤ 0.04	2 pieces allowed
defects		≤ 3.0	≤ 0.05	Accept 1
		-	> 0.05	NG
		requirements. 2. When the line i round object and 3. When the lengt as internal pollution time, the distance	ten both length and is 3/4 of a circle, it is judged as internal j th>5 or the width>0 on; when both appe e must be greater th ual area is not cou	s judged as a pollution. .04, it is inspected ear at the same nan 5.0mm.
1.Polarizer impurities 2. Bubbles 3. Concave and convex spots 4. Puncture wounds 5.Water pattern	There is 1. Dirt between the polarizer and the glass. 2. Concave or convex caused by air	<ul> <li>4. Outside the visual area is not counted</li> <li>1. The visible area is inspected according to the point defect standard, and the area outside the visible area is not counted. 2. The bubble caused by the object must be at least 0.2mm away from the visible area.</li> <li>3. No more than 1/3 LCD, 1 line is allowed.</li> </ul>		

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Polarizer is crooked		
External silk	_	

screen bubble

1. Polarizers are not allowed to extend beyond the edge of the glass.

 The distance between the polarizer and the edge of the glass should not exceed 1.5mm and at least 0.2mm should not enter the visible area..

The width of the bubble should not exceed 0.25mm, and there should be no obvious black shadow.

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Powder
(lump)

-

Inspect by point or line defects.

Defective item	Legend	Testing standards
Crack	a a a a a a a a a a a a a a a a a a a	Not allowed, the crack can be removed and tested for damage
Background	Some or all of the background color of the LCD product is different from the background color of the sample.	There must not be any obvious color difference between the base color of the product and the base color of the sample confirmed by the customer. Otherwise, the plate will be checked and packaged separately. (Confirmation by the customer is required if necessary)
rainbow	There is obvious color difference on the same piece of glass	Not allowed, limit plate can be made for inspection. (Customer confirmation is required if necessary)
1. The sealing glue is too long 2. Too high 3. Off position	 	<ol> <li>The height or length shall be subject to the dimension tolerance of the engineering drawing.</li> <li>The deviation is not allowed.</li> </ol>
Poor sealing glue penetrati on		The minimum penetration of the sealing glue is 1/3 of the distance from the glass edge to the retaining line, and the maximum penetration does not enter the visible area.
Sealing glue falls off	-	Not Allowed
The crystal is not full	-	Not Allowed
Uneven frame lines		<ol> <li>≥3/2 of the average frame width or ≤1/2 of the average frame width, rejected.</li> <li>Rejected if entering the visible area.</li> </ol>
Uneven edges	A	1.A ≤ 0.2mm, accepted 2.A > 0.2mm, rejected

#### 2. Damage inspection

Note: "X" indicates the damaged length and "D" indicates the PIN width"Y" indicates the crack width "Z" indicates the crack thickness "T" indicates the thickness of a single piece of glass		
Defective item	Legend	Testing Standard
General	Kr.	1. X direction is not limited.
damage 1. Non- electrode	Y YL	2. Y direction does not enter the visible area, it is acceptable.
area Glass surface	X	3. Z does not cause ≤1/3 frame line leakage, it is acceptable.
2. Surface bonding area Damage	, in the second se	Note: X, Y, Z must be considered at the same time during inspection. If any one of them fails, it will be judged as NG.
LCD defect		1. No limit in X direction.
detection details (Level B)		2. Acceptable if 1/3 of the frame line is not entered in Y and Z directions or 1/3 of the silver point is leaking outside.
		Note: X, Y and Z must be considered at the same time during inspection. If one of them fails, it will be judged as NG.
LCD defect detection	\	1. No limit in X direction.
details (Level B)		2. Acceptable if 1/3 of the frame line is not entered in Y and Z directions or 1/3 of the silver point is leaking outside.
	电极端子区	Note: X, Y and Z must be considered at the same time during inspection. If one of them fails, it will be judged as NG.
LCD defect detection	Tz	1. No limit in X direction.
details (Level B)		2. Acceptable if 1/3 of the frame line is not entered in Y and Z directions or 1/3 of the silver point is leaking outside.
		Note: X, Y and Z must be considered at the same time during inspection. If one of them fails, it will be judged as NG.

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## 3. Telecommunications performance test

Defective item	Legend	Testing standard
Legend	After power on, the displayed pen segment is not displayed	Not allowed
High current	After passing normal voltage, the product current consumption reaches or exceeds the set value	<ol> <li>Not allowed</li> <li>If necessary, the current limit needs to be agreed with the customer</li> </ol>
Short circuit	-	Not allowed
Font diffusion	During normal electrical testing, part or all of the pen segments become thicker.	Not allowed
1. White 2. Pinhole	$\Phi = \frac{W + L}{2}$	<ul> <li>Controlled as point defects and Φ is less than 1/3 of the width of the pen segment.</li> <li>(Limited sample inspection can be performed if necessary).</li> </ul>
1. Concave and convex points 2. Multiple strokes Combination		Controlled as point defects and W is less than $1/2$ of the width of the pen segment. If necessary, a limit sample test can be performed. 1. (A-B) $\leq$ 0.2mm is
		acceptable. 2. B/A $\ge$ 3/4 is acceptable. Multiple scratches caused by combined deflection are inspected according to the point and line standard If necessary, a limit plate can be used for inspection
Light and dark strokes	The pen segments are unstable, dark or missing	Not allowed

	due to poor contact of the conductive points.	
Light words	-	It is not allowed. If necessary, a limit template can be established for control.
Threshold voltage	-	<ol> <li>≤1/4Duty is controlled by ±0.04V according to the sample confirmed by the customer.</li> <li>&gt;1/4Duty is controlled by ±0.03V.</li> </ol>

## 4. Installation pin inspection

Defective item	Legend	Testing standard
Pins are crooked	The clamp and the electrode terminal are not on the same line (at an	1.c>5° is not allowed 2.Does not meet the requirements of the
	angle of φ)	engineering drawing is not allowed
		The skew of the PIN foot in the X or Y direction does
PIN skew		not exceed 5°. There
	. TTT	should be no distortion within 5mm of the PIN end.
	- z	The chuck deviation must
Chuck bias		be $\leq$ the conductive wire
		width ±0.2mm.
Glue bubbles		Not allowed to connect to PIN
Glue Cutting		Not Allowed
There is glue outside the chuck		Not Allowed
Glue seeps into polarizer		Not Allowed
		1. Exceeding the height of
		the upper polarizer: Not
Glue height		allowed (B in the figure) Lower polarizer
		2. 1.0mm (H1-H>1.0mm):
		Not allowed
No glue around the chuck	B	Not allowed (A in the
		figure)
·	H, H	Wrap each chuck, fill the
Glue shape		gap, make the surface
		smooth without depression,
		and no glue clumps on the back.
	~	The glue is not allowed to
Olive met come d		be completely cured (if the
Glue not cured	-	glue does not stick to your
		fingers when pressed, it is

		OK, otherwise it is NG).
The pin is not installed to the bottom	-	Not Allowed
Conductive adhesive offset	-	The PIN chuck should not exceed 0.2mm
PIN bevel cutting	-	Control according to engineering drawing requirements.
PIN shape	-	After PIN cutting, there should be no hooks, no obvious bending or deformation, and no obvious damage to the coating.

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5. Product internal and external silk screen inspection

Defective items	Legend	Testing Standard
Pattern	-	Subject to the sample confirmed by the customer
color		
Wrong ink	-	Not allowed
Position	-	Controlled by the requirements of the engineering
offset		drawing (screen printing film can be checked)
Tilted	-	Controlled by the requirements of the engineering
pattern		drawing (screen printing film can be checked)), the
		maximum tilt angle is ±1º.
Broken silk	-	Inspected according to the linear defect standard
screen		
Missing	-	Not allowed (screen printing film can be checked)
pattern		
Blurred	-	Inspected according to the sample confirmed by the
pattern		customer
1. Hairy	-	Meet the requirements of engineering drawings, visual
lines 2.		lines are smooth, and the width of burrs or the length of
Wiredrawin		wire drawing does not exceed 0.1mm
g		
Scratched	-	Inspect according to the appearance linear defect
pattern		standard
Line width	-	Control according to the requirements of the engineering
		drawing (can be checked by silk screen film matching).
1. Dirty	-	
spots 2.		Inspection according to point defect standards
Bubbles on		
the pattern		
Uneven line	_	Meet the requirements of engineering drawings, visual
thickness		lines are smooth, and line thickness changes within $\pm$
		0.1mm